## Notice of References Cited Application/Control No. 10/663,210 Examiner TUYEN T NGUYEN Applicant(s)/Patent Under Reexamination SEIDLER, DAVID Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-6,631,806	10-2003	Jackson, Ellen R.	206/581
X	В	US-5,373,862	12-1994	Blachut, Longin	132/294
X	С	US-5,135,012	08-1992	Kamen et al.	132/294
X	D	US-5,005,697	04-1991	Jimbo et al.	206/235
X	Е	US-4,045,291	08-1977	Berger, Jacob E.	435/297.5
П	F	US-			
	G	US-			
	Η	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				<i>1</i>	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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